Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/725,242	YOSHIOKA ET AL.	
Examiner	Art Unit	

Vanel Frenel

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	SEARCHED				
Class	Subclass	Date	Examiner		
705	26	3/15/2007	V.F		
342	457	3/15/2007	V.Ę		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
705	26	3/15/2007	V.F	
342	457	3/15/2007	V.F	

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West 2.0	3/15/2007	V.F
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